## Index of Claims 10576220 Examiner MARCOS BATISTA Applicant(s)/Patent Under Reexamination LEE ET AL. Art Unit 2617

<b>✓</b>	Rejected	-	Cancelled	N	Non-Elected	Α	Appeal
II	Allowed	÷	Restricted	I	Interference	0	Objected

CL	AIM	DATE									
Final	Original	02/19/2008	07/15/2008								
	1	√ ×	√ ×								
	2	<b>√</b>	<b>√</b>								
	3	<b>√</b>	<b>✓</b>								
	4	<b>√</b>	<b>√</b>								
	5	<b>√</b>	<b>√</b>								
	6	<b>√</b>	<b>√</b>								
	7	<b>√</b>	<b>√</b>								
	8	<b>√</b>	<b>√</b>								
	9	✓	<b>√</b>								
	10	<b>√</b>	<b>√</b>								
	11	✓	<b>✓</b>								
	12	✓	✓								
	13	<b>√</b>	<b>√</b>								
	14	<b>√</b>	✓								
	15	<b>√</b>	✓								
	16	✓	✓								
	17	<b>√</b>	✓								
	18	✓	-								
	19	✓	✓								
	20	✓	✓								
	21	✓	✓								
	22	✓	✓								
	23	✓	✓								
	24	✓	✓								
	25	✓	✓								
	26	✓	✓								
	27	✓	✓								
	28	✓	✓								
	29	✓	✓								
	30	✓	✓								
	31	✓	✓								
	32	✓	✓								
	33	✓	✓								
	34	✓	✓								
	35	✓	✓								

	Application/Control No.	Applicant(s)/Patent Under Reexamination				
Index of Claims	10576220	LEE ET AL.				
	Examiner	Art Unit				
	MARCOS BATISTA	2617				

✓ Rejected		-	- Cancelled		N	N Non-Elected			A A		opeal		
=	= Allowed		÷	Res	tricted	I	I Interference			0	Objected		
☐ Claims renumbered in the same order as presented by applicant ☐								□ СРА		] T.D	).	R.1.47	
	CLA	IM					DATE						
Fi	nal	Original	02/19/2008	07/15/2008									
		37	✓	✓									

38

39 40

41 42 ✓

✓

✓

✓

✓

U.S. Patent and Trademark Office Part of Paper No.: 20080715